

TWO U.S.-CHINA JCCT EVENTS

On January 30 - 31, 2007, the U.S. Department of Commerce and Ministry of Information Industry, in support of the U.S.-China Joint Commission on Commerce and Trade (JCCT), have planned two events in Beijing, China: the ICT Standards and Conformity Assessment Seminar and the RFID Industry and Applications Seminar.

ICT Standards and Conformity Assessment Seminar

On January 30, 2007, the sixth information and communications Technology (ICT) Standards and Conformity Assessment Seminar will be held and will allow U.S. and Chinese Government and private sector representatives to share their experiences on a number of different topics. Among others, this year's seminar topics will include: 1) China's restrictions on hazardous substances (RoHS); 2) standards development and the innovation cycle; 3) how to participate in China's industry association standards development; and, 4) new developments in the U.S. and China in the conformity assessment field.

RFID Industry and Applications Seminar

On January 31, 2007, the first Sino-U.S. Seminar on RFID Industry and Applications is planned and will provide a forum for U.S. and Chinese Government and private sector representatives to begin a dialogue on various RFID applications and issues. This event will include: 1) societal applications and issues such as anti-counterfeiting, and food and agricultural safety, 2) business process applications, 3) the status of current RFID industry development; and, 4) trends in spectrum allocation and the challenges of RFID interoperability.

Interested parties wishing to attend should submit their name, title, affiliation, phone number and email to: jon.boyens@mail.doc.gov (ICT Standards and Conformity Assessment) or robin.gaines@mail.doc.gov (RFID) no later than January 23, 2007. For more information, please contact Jon Boyens or Robin Gaines at the above contact information.